

S13362-3050DG

MPPC[®] (Multi-Pixel Photon Counter)

S13362 series

Significantly reduced crosstalk, low afterpulses

The S13362 series can reduce dark count by cooling in addition to low afterpulses and low crosstalk of the S13360 series. The S13362 series integrates the S13360 series with thermoelectric cooler. The photosensitive area is available in two sizes of 1.3×1.3 mm and 3.0×3.0 mm.

🕨 Features

- Significantly reduced crosstalk
- Low afterpulses
- Superior photon counting capability
- Low voltage (VBR=51.1 V typ.) operation
- High gain: 10⁵ to 10⁶
- Low dark count (no more than 1/20 the count at room temperature by cooling)
- Operates with simple readout circuit

Applications

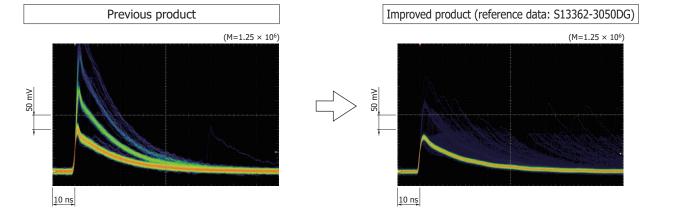
- Low light level detection
- Scattered light measurement
- Fluorescence measurement
- Laser microscopes
- Flow cytometry
- DNA sequencers
- Environmental analysis
- Various academic research

Lower noise

When an MPPC detects photons, the output may contain spurious pulses, namely afterpulse and crosstalk, that are separate from the output pulses of the incident photons. Afterpulses are output later than the timing at which the incident light is received. Crosstalk is output from other pixels at the same time as the detection of light.

Previous products achieved lower afterpulse through the improvement of material and wafer process technology, but with the S13362 series, low crosstalk has been achieved in addition to low afterpulse.

D Pulse waveform comparison (typical example)



MPPC (Multi-Pixel Photon Counter)

Structure

Parameter	S13362		
Parameter	-1350DG	-3050DG	– Unit
Effective photosensitive area	1.3 × 1.3	3.0×3.0	mm
Pixel pitch	50		
Number of pixels	667	3600	-
Fill factor	74		
Package	Metal (TO-8)		
Window	Borosilicate glass		
Refractive index of window material	1.52		
Cooling	Two-stage TE-cooling		

Absolute maximum ratings

Parameter	Symbol	Value	Unit
Operating temperature*1	Topr	-20 to +60	°C
Storage temperature ^{*1}	Tstg	-20 to +85	°C
Chip temperature	Tchip	-25 to ambient temperature	°C
Thermistor power dissipation	Pd_th	0.2	mW
TE-cooler allowable current	ITE max	1	A
TE-cooler allowable voltage	VTE max	0.9	V
Soldering temperature*2	Tsol	350 ^{*3} (3 s or less once)	°C

*1: No dew condensation

When there is a temperature difference between a product and the surrounding area in high humidity environment, dew condensation may occur on the product surface. Dew condensation on the product may cause deterioration in characteristics and reliability.

*2: At least 1 mm away from lead root

*3: Soldering iron tip

Note: Exceeding the absolute maximum ratings even momentarily may cause a drop in product quality. Always be sure to use the product within the absolute maximum ratings.

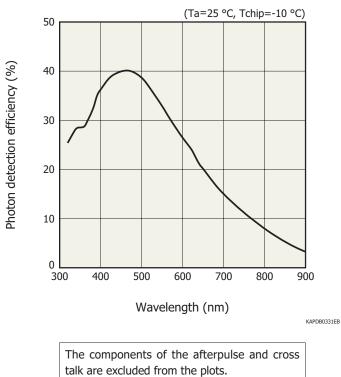
Electrical and optical characteristics (Typ. Ta=25 °C, Tchip=-10 °C, unless otherwise noted)

Parameter		Symbol	S13362		
		Symbol	-1350DG	-3050DG	- Unit
Spectral response range		λ	320 to 900		nm
Peak sensitivity wavelength		λр	450		nm
Breakdown voltage		VBR	51.1 ± 5		V
Photon detection efficiency at λp ^{*4} PDE 40		0	%		
Recommended operating voltage Vo		Vop	VBR + 3		V
Dark count	Тур.		5	25	kene
	Max.	-	13	72	kcps
Crosstalk probability		-	3		%
Terminal capacitance		Ct	60	320	pF
Gain		М	1.7 × 10 ⁶		-
Temperature coefficient of recommended reverse voltage		ΔTVop	54		mV/°C
Recommended temperature of TE-cooler TTE_recom		-10		°C	

*4: Photon detection efficiency does not include crosstalk and afterpulses.

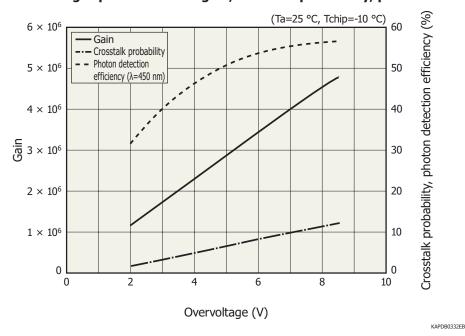
Note: The above characteristics were measured at the operating voltage that yields the listed gain. (See the data attached to each product.)





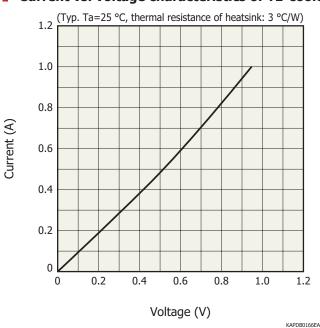
Photon detection efficiency vs. wavelength (typical example)





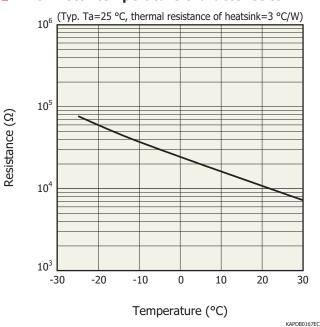
MPPC characteristics vary with the operating voltage. Although increasing the operating voltage improves the photon detection efficiency and time resolution, it also increases the dark count and crosstalk at the same time, so an optimum operating voltage must be selected to match the application.



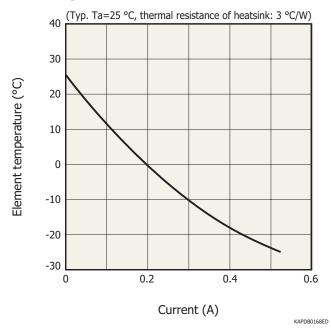


- Current vs. voltage characteristics of TE-cooler



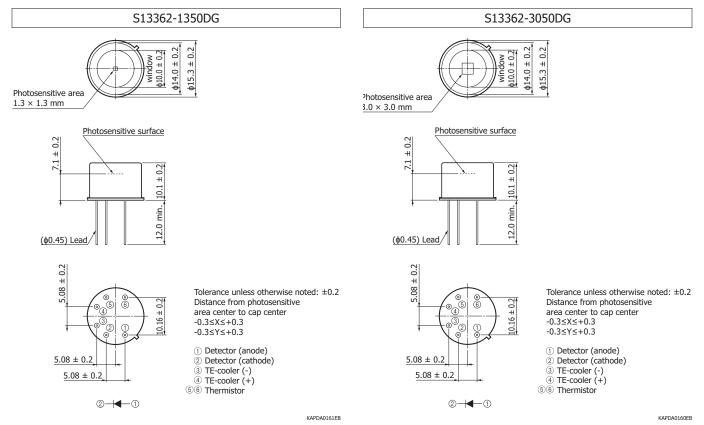


- Cooling characteristics of TE-cooler





Dimensional outlines (unit: mm)



Related information

www.hamamatsu.com/sp/ssd/doc_en.html

- Precautions
- · Disclaimer
- \cdot Metal, ceramic, plastic package products



[Related products] MPPC module C13366 series

The C13366 series (GA type and GD type) are optical measurement modules capable of detecting low level light. These modules consist of a thermoelectrically cooled MPPC, an amplifier, a high-voltage power supply circuit, and a temperature control circuit. The photosensitive area is available in two sizes of 1.3×1.3 mm and 3×3 mm. Modules operate just by connecting them to an external power supply $(\pm 5 \text{ V})$.



Type no.	Built-in MPPC	Photosensitive area (mm)	Pixel pitch (µm)	Cooling	Supply voltage	Feature
C13366-1350GA	S13362-1350DG	1.3×1.3	50	TE cooled	cooled ±5 V ±5 V	Analog output
C13366-3050GA	S13362-3050DG	3 × 3				
C13366-1350GD	S13362-1350DG	1.3×1.3		I E-COOIEU		Digital output
C13366-3050GD	S13362-3050DG	3 × 3				

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Information described in this material is current as of December 2020.

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